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APPLICATION NO. CONT/PRIOR CLASS SUBCLASS ART UNIT EXAMINER
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Shunpei Yamazaki Hideomi Suzawa

Dry etching apparatus, etching method. and method of forming a wiring

PTO-2040

		ISSUING C	LASSIFICATION				
ORIGINA	AL	CROSS REFERENCE(S)					
CLASS	SUBCLASS	CLASS	SS SUBCLASS (ONE SUBCLASS PER BLOCK)				
INTERNATIONAL	L CLASSIFICATION						
			Continued on Issue Slip Inside File Jacket				

TERMINAL	DRAWINGS			CLAIMS ALLOWED	
— DISCLAIMER	Sheets Drwg.	Figs. Drwg.	Print Fig.	Total Claims	Print Claim for O.G.
The term of this patent subsequent to (date)				NOTICE OF ALI	LOWANCE MAILED
has been disclaimed.	(Assistant Examiner)		(Date)		
The term of this patent shall not extend beyond the expiration date					
of U.S Patent. No.				ISSUE FEE	
				Amount Due	Date Paid
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The terminalmonths of this patent have been disclaimed.				ISSUE BA	TCH NUMBER
	(Legal Instrume	nts Examiner)	(Date)		
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orm PTO-436A Rev. 6/99)	FILED WITH:			DISK (CRF)	FICHE CD-RON
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